

Absolute Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Collector-Base Voltage	V _{CBO}	-40	V
Collector-Emitter Voltage	V _{CEO}	-40	V
Emitter-Base Voltage	V _{EBO}	-5.0	V
Collector Current - Continuous (Note 5)	Ic	-200	mA

Thermal Characteristics

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 5)	PD	300	mW
Thermal Resistance, Junction to Ambient (Note 5)	$R_{ ext{ heta}JA}$	417	°C/W
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C

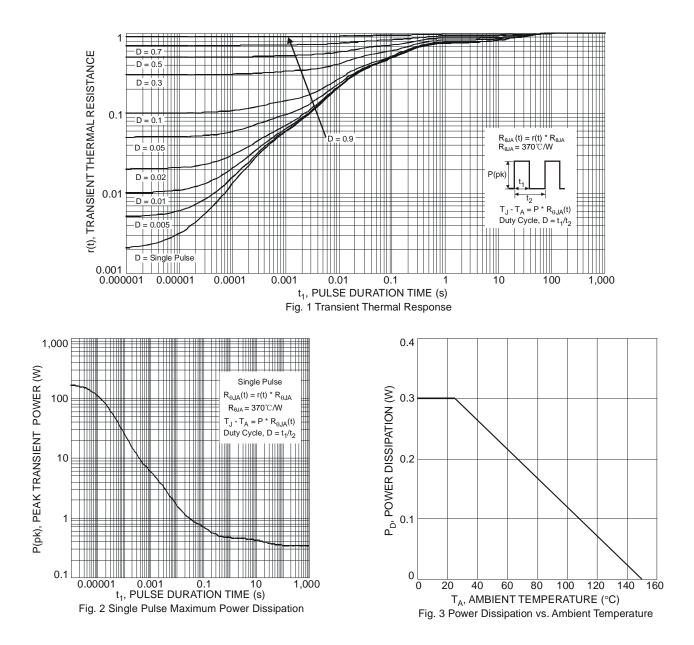
ESD Ratings (Note 6)

Characteristic	Symbol	Value	Unit	JEDEC Class
Electrostatic Discharge - Human Body Model	ESD HBM	4,000	V	3B
Electrostatic Discharge - Machine Model	ESD MM	400	V	С

Notes: 5. Device mounted on FR-4 PCB with minimum recommended pad layout. 6. Refer to JEDEC specification JESD22-A114 and JESD22-A115.



Thermal Characteristics and Derating Information





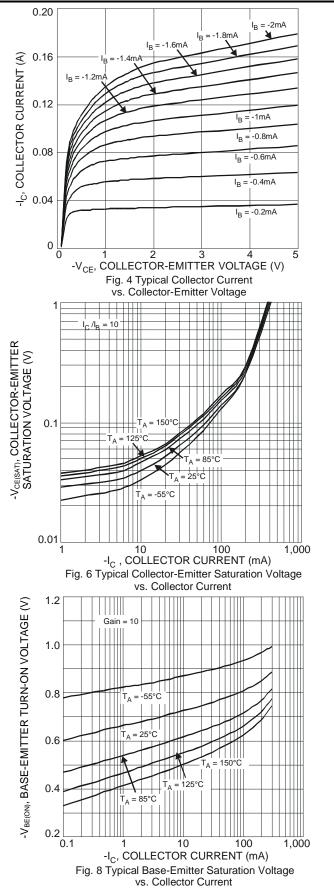
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

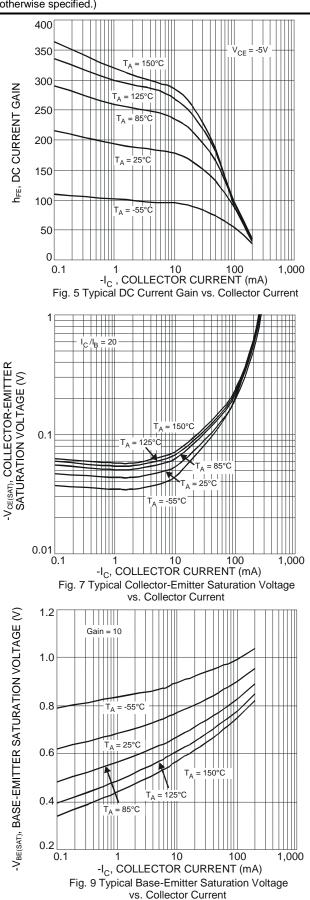
Characteristic	Symbol	Min	Max	Unit	Test Condition
OFF CHARACTERISTICS					
Collector-Base Breakdown Voltage	V _{(BR)CBO}	-40	_	V	$I_{\rm C} = -10 \mu A, I_{\rm E} = 0$
Collector-Emitter Breakdown Voltage (Note 7)	V _{(BR)CEO}	-40	_	V	$I_{\rm C} = -1 {\rm mA}, I_{\rm B} = 0$
Emitter-Base Breakdown Voltage	V _{(BR)EBO}	-6	_	V	$I_{E} = -10\mu A, I_{C} = 0$
Collector Cutoff Current	ICEX	_	-50	nA	$V_{CE} = -30V, V_{EB(OFF)} = -3V$
	I _{CBO}	_	-50	nA	$V_{CB} = -30V, I_E = 0$
Base Cutoff Current	I _{BL}		-50	nA	$V_{CE} = -30V, V_{EB(OFF)} = -3V$
ON CHARACTERISTICS (Note 7)					
		60	_		$I_{C} = -100 \mu A, V_{CE} = -1V$
		80			$I_{C} = -1.0 \text{mA}, V_{CE} = -1 \text{V}$
DC Current Gain	h _{FE}	100	300	—	$I_{C} = -10mA, V_{CE} = -1V$
		60 30			$I_{C} = -50 \text{mA}, V_{CE} = -1 \text{V}$
		30			$I_{C} = -100 \text{mA}, V_{CE} = -1 \text{V}$
Collector-Emitter Saturation Voltage	V _{CE(SAT)}	_	-0.25	V	$I_{C} = -10mA$, $I_{B} = -1mA$
	02(0/11)		-0.40		$I_{C} = -50 \text{mA}, I_{B} = -5 \text{mA}$
Base-Emitter Saturation Voltage	V _{BE(SAT)}	-0.65	-0.85	V	$I_{C} = -10mA, I_{B} = -1mA$
SMALL SIGNAL CHARACTERISTICS	()		-0.95		$I_{\rm C} = -50 {\rm mA}, I_{\rm B} = -5 {\rm mA}$
Output Capacitance			4.5	~	
Input Capacitance	C _{OBO}	_	4.5	pF pF	$V_{CB} = -5V, f = 1MHz, I_E = 0$
	C _{IBO}		-		$V_{EB} = -0.5V, f = 1MHz, I_C = 0$
Input Impedance	h _{ie}	2	12 10	kΩ	-
Voltage Feedback Ratio	h _{re}	0.1		x 10 ⁻⁴	$V_{CE} = -10V, I_{C} = -1mA,$ f = 1kHz
Small Signal Current Gain	h _{fe}	100	400		
Output Admittance	h _{oe}	3	60	μS	
Current Gain-Bandwidth Product	f⊤	300	—	MHz	$V_{CE} = -20V, I_C = -10mA,$ f = 100MHz
SWITCHING CHARACTERISTICS				•	
Delay Time	t _D		35	ns	$V_{CC} = -3V, I_{C} = -10mA,$
Rise Time	t _R		35	ns	I _{B1} = -1mA
Storage Time	ts		225	ns	$V_{CC} = -3V, I_{C} = -10mA,$
Fall Time	t _F		75	ns	$I_{B2} = 1mA$

Note: 7. Measured under pulsed conditions. Pulse width \leq 300µs. Duty cycle \leq 2%.



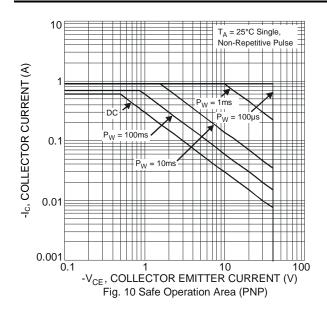
Typical Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)





DST3906DJ Document number: DS32039 Rev. 3 - 2 Downloaded from Arrow.com.



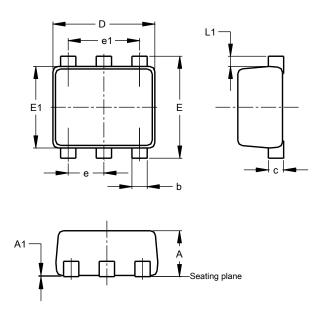




Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

SOT963

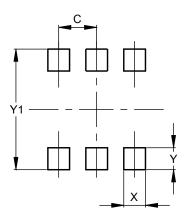


SOT963				
Dim	Min	Max	Тур	
Α	0.40	0.50	0.45	
A1	0.00	0.05		
b	0.10	0.20	0.15	
С	0.120	0.180	0.150	
D	0.95	1.05	1.00	
E	0.95	1.05	1.00	
E1	0.75	0.85	0.80	
е		-	0.35	
e1			0.70	
L1	0.05	0.15	0.10	
All	All Dimensions in mm			

Suggest Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

SOT963



Dimensions	Value (in mm)		
С	0.350		
Х	0.200		
Y	0.200		
Y1	1.100		

Note:

The suggested land pattern dimensions have been provided for reference only, as actual pad layouts may vary depending on application. These dimensions may be modified based on user equipment capability or fabrication criteria. A more robust pattern may be desired for wave soldering and is calculated by adding 0.2mm to the 'Z' dimension. For further information, please reference document IPC-7351A, Naming Convention for Standard SMT Land Patterns, and for International grid details, please see document IEC, Publication 97.



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